# **Power MOSFET** 25 V, 89 A, Single N-Channel, DPAK/IPAK

#### Features

- Trench Technology
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These are Pb-Free Devices

#### Applications

- VCORE Applications
- DC-DC Converters
- Low Side Switching

	$G_{3}(1) = 2$	5 C uniess ou	ierwise state	eu)	
Para	ameter		Symbol	Value	Unit
Drain-to-Source Vol	Drain-to-Source Voltage			25	V
Gate-to-Source Volt	Gate-to-Source Voltage			±20	V
Continuous Drain Current R <sub>0.1A</sub>		T <sub>A</sub> = 25°C	Ι <sub>D</sub>	16.8	A
(Note 1)		T <sub>A</sub> = 85°C		13.0	
Power Dissipation $R_{\theta JA}$ (Note 1)		T <sub>A</sub> = 25°C	PD	2.14	W
Continuous Drain Current R <sub>0JA</sub>		T <sub>A</sub> = 25°C	ID	13.3	А
(Note 2)	Steady	T <sub>A</sub> = 85°C		10.3	
Power Dissipation $R_{\theta JA}$ (Note 2)	State	T <sub>A</sub> = 25°C	PD	1.33	W
Continuous Drain Current R <sub>0.IC</sub>		T <sub>C</sub> = 25°C	Ι <sub>D</sub>	89	A
(Note 1)		T <sub>C</sub> = 85°C		69	
Power Dissipation $R_{\theta JC}$ (Note 1)		T <sub>C</sub> = 25°C	PD	60	W
Pulsed Drain Current	t <sub>p</sub> =10μs	T <sub>A</sub> = 25°C	I <sub>DM</sub>	179	A
Current Limited by P	ackage	T <sub>A</sub> = 25°C	I <sub>DmaxPkg</sub>	45	А
Operating Junction a Temperature	ind Storage		T <sub>J</sub> , T <sub>STG</sub>	-55 to +175	°C
Source Current (Bod	Source Current (Body Diode)			50	А
Drain to Source dV/dt			dV/dt	6	V/ns
Energy (T <sub>J</sub> = 25°C, $V_{L}$ = 19 A <sub>pk</sub> , L = 1.0 m	Single Pulse Drain-to-Source Avalanche Energy (T <sub>J</sub> = 25°C, V <sub>DD</sub> = 50 V, V <sub>GS</sub> = 10 V, I <sub>L</sub> = 19 A <sub>pk</sub> , L = 1.0 mH, R <sub>G</sub> = 25 $\Omega$ )		EAS	180.5	mJ
Lead Temperature for (1/8" from case for 1		Purposes	ΤL	260	°C

### **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise stated)

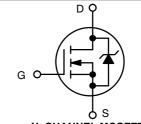
Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.



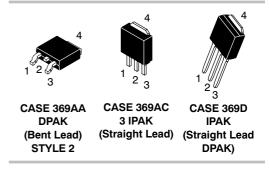
# **ON Semiconductor®**

#### http://onsemi.com

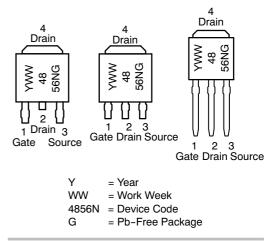
V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
25 V	$4.7~\mathrm{m}\Omega @ 10~\mathrm{V}$	89 A
20 1	6.8 mΩ @ 4.5 V	69 A



N-CHANNEL MOSFET







#### **ORDERING INFORMATION**

See detailed ordering and shipping information in the package dimensions section on page 6 of this data sheet.

#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ ext{ heta}JC}$	2.5	°C/W
Junction-to-TAB (Drain)	$R_{\thetaJC-TAB}$	3.5	
Junction-to-Ambient – Steady State (Note 1)	$R_{\thetaJA}$	70	
Junction-to-Ambient – Steady State (Note 2)	$R_{\thetaJA}$	113	

Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
Surface-mounted on FR4 board using the minimum recommended pad size.

#### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise specified)

Parameter	Symbol	Test Cond	lition	Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 V, I_D =$	= 250 μA	25			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> / T <sub>J</sub>				23		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 20 V	T <sub>J</sub> = 25°C T <sub>.1</sub> = 125°C			1.0 10	μA
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub>	J.			±100	nA
ON CHARACTERISTICS (Note 3)	•						
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_{D}$	= 250 μA	1.45		2.5	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				5.9		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 30 A		3.9	4.7	
		V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 30 A		5.3	6.8	mΩ
Forward Transconductance	<b>9</b> FS	V <sub>DS</sub> = 1.5 V, I	l <sub>D</sub> = 15 A		73		S
CHARGES AND CAPACITANCES							
Input Capacitance	C <sub>ISS</sub>				2241		pF
Output Capacitance	C <sub>OSS</sub>	V <sub>GS</sub> = 0 V, f = 1.0 M	Hz, V <sub>DS</sub> = 12 V		567		
Reverse Transfer Capacitance	C <sub>RSS</sub>				279		
Total Gate Charge	Q <sub>G(TOT)</sub>				18	27	nC
Threshold Gate Charge	Q <sub>G(TH)</sub>		15 \/ 1 00 4		3.4		
Gate-to-Source Charge	Q <sub>GS</sub>	$V_{GS}$ = 4.5 V, $V_{DS}$ =	15 V, I <sub>D</sub> = 30 A		6.7		
Gate-to-Drain Charge	Q <sub>GD</sub>				6.6		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = <sup>-</sup>	15 V, I <sub>D</sub> = 30 A		38		nC
SWITCHING CHARACTERISTICS (Note	4)						
Turn-On Delay Time	t <sub>d(ON)</sub>				15.7		
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 4.5 V, V <sub>I</sub>	<sub>ns</sub> = 15 V,		22.5		1
Turn-Off Delay Time	t <sub>d(OFF)</sub>	V <sub>GS</sub> = 4.5 V, V <sub>I</sub> I <sub>D</sub> = 15 A, R <sub>G</sub>	= 3.0 Ω		18.6		ns
Fall Time	t <sub>f</sub>				7.5		1
Turn-On Delay Time	t <sub>d(ON)</sub>				8.7		
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 11.5 V. V	′ <sub>DS</sub> = 15 V,		17.5		1
Turn-Off Delay Time	t <sub>d(OFF)</sub>	V <sub>GS</sub> = 11.5 V, V I <sub>D</sub> = 15 A, R <sub>G</sub>	= 3.0 Ω		27.2		ns

Fall Time

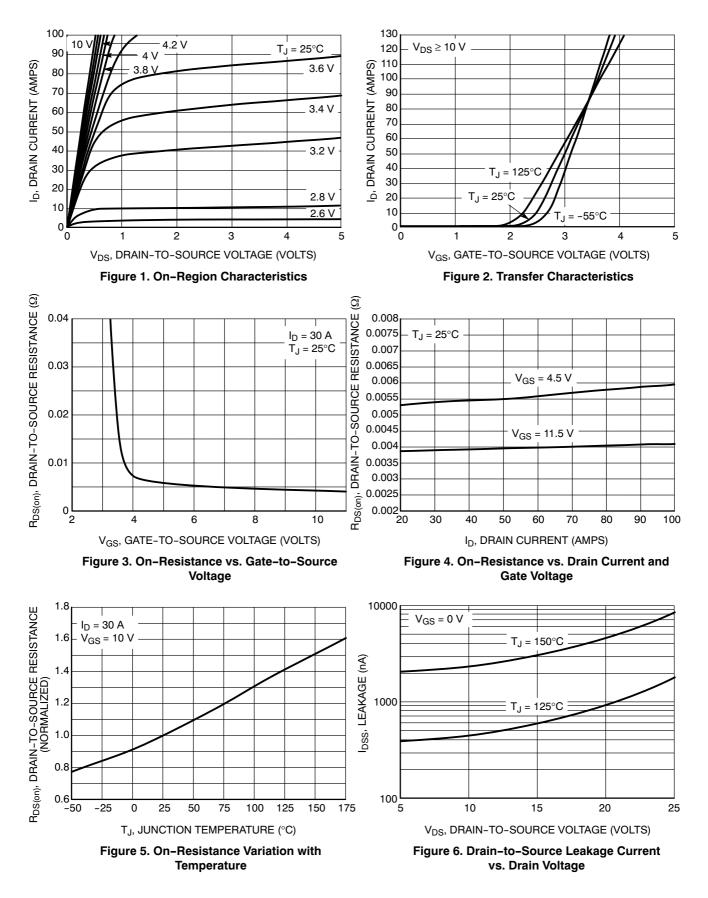
t<sub>f</sub>

4.0

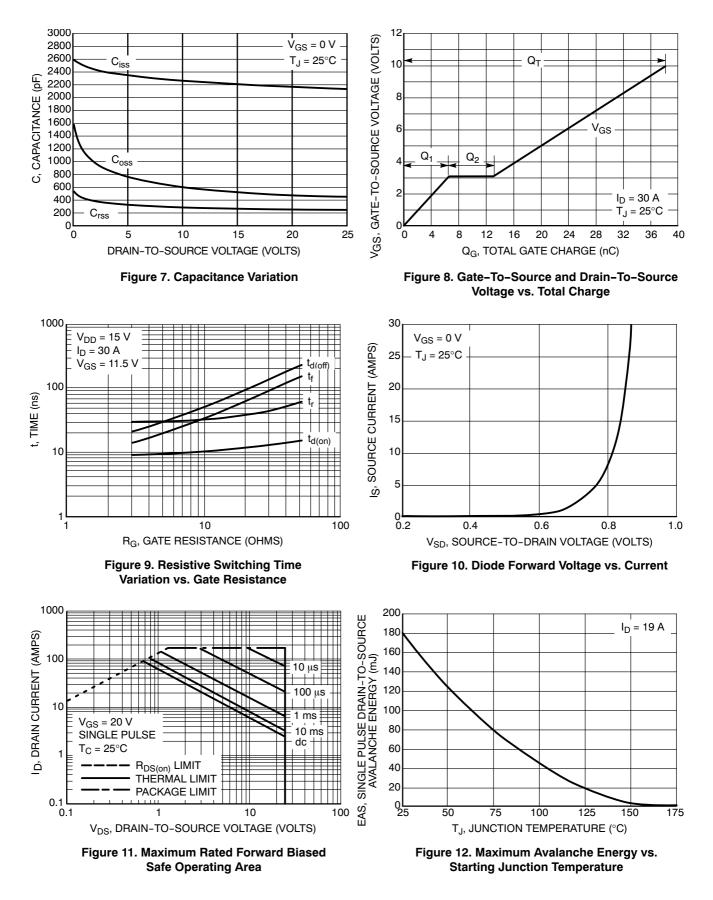
# **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
DRAIN-SOURCE DIODE CHARACT	ERISTICS						
Forward Diode Voltage	V <sub>SD</sub>	$V_{GS} = 0 V.$	$T_J = 25^{\circ}C$		0.87	1.2	V
		V <sub>GS</sub> = 0 V, I <sub>S</sub> = 30 A	T <sub>J</sub> = 125°C		0.72		V
Reverse Recovery Time	t <sub>RR</sub>				18.7		ns
Charge Time	t <sub>a</sub>	V <sub>GS</sub> = 0 V, dIS/dt	t = 100 A/μs,		9.3		
Discharge Time	t <sub>b</sub>	$\label{eq:VGS} \begin{array}{l} V_{GS} = 0 \text{ V, } dIS/dt = 100 \text{ A}/\mu\text{s}, \\ I_S = 30 \text{ A} \end{array}$			9.4		
Reverse Recovery Charge	Q <sub>RR</sub>				8.0		nC
PACKAGE PARASITIC VALUES							
Source Inductance	L <sub>S</sub>				2.49		nH
Drain Inductance, DPAK	L <sub>D</sub>				0.0164		
Drain Inductance, IPAK	L <sub>D</sub>	T <sub>A</sub> = 25°C			1.88		
Gate Inductance	L <sub>G</sub>				3.46		1
Gate Resistance	R <sub>G</sub>				0.6		Ω

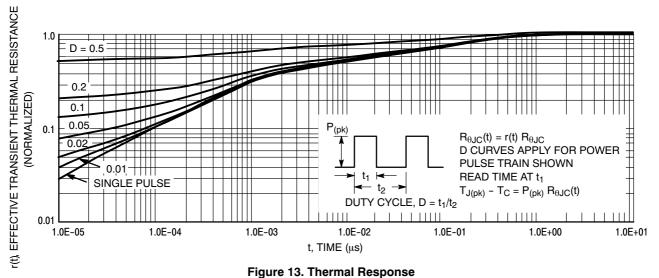
#### **TYPICAL PERFORMANCE CURVES**



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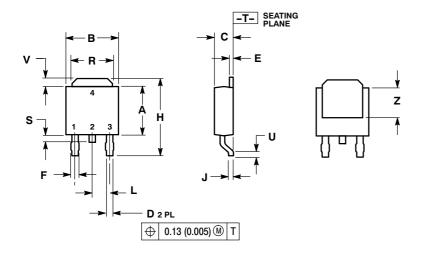
#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>	
NTD4856NT4G	DPAK (Pb-Free)	2500 / Tape & Reel	
NTD4856N-1G IPAK (Pb-Free)		75 Units / Rail	
NTD4856N-35G	IPAK Trimmed Lead (3.5 $\pm$ 0.15 mm) (Pb-Free)	75 Units / Rail	

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### **PACKAGE DIMENSIONS**

**DPAK (SINGLE GAUGE)** CASE 369AA-01 ISSUE A



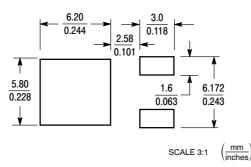
NOTES: 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROL LING DIMENSION; INCH. 2.

	INC	HES	MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	0.235	0.245	5.97	6.22	
В	0.250	0.265	6.35	6.73	
С	0.086	0.094	2.19	2.38	
D	0.025	0.035	0.63	0.89	
Е	0.018	0.024	0.46	0.61	
F	0.030	0.045	0.77	1.14	
н	0.386	0.410	9.80	10.40	
J	0.018	0.023	0.46	0.58	
L	0.090	BSC	2.29	BSC	
R	0.180	0.215	4.57	5.45	
S	0.024	0.040	0.60	1.01	
U	0.020		0.51		
V	0.035	0.050	0.89	1.27	
Z	0.155		3.93		

STYLE 2:

PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

**SOLDERING FOOTPRINT\*** 

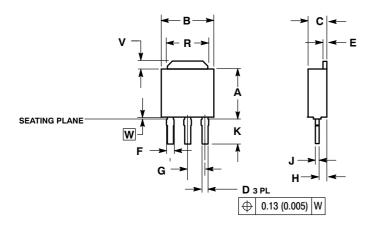


\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

#### PACKAGE DIMENSIONS

#### **3 IPAK, STRAIGHT LEAD** CASE 369AC-01

ISSUE O



#### PER ANSI Y14.5M, 1982. CONTROLLING DIMENSION: INCH. SEATING PLANE IS ON TOP OF DAMBAR POSITION. 3.

NOTES

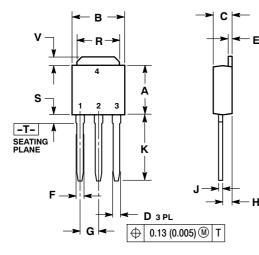
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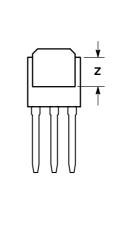
DIMENSION A DOES NOT INCLUDE 4. DAMBAR POSITION OR MOLD GATE.

1.. DIMENSIONING AND TOLERANCING

	INC	HES	MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	0.235	0.245	5.97	6.22	
в	0.250	0.265	6.35	6.73	
С	0.086	0.094	2.19	2.38	
D	0.027	0.035	0.69	0.88	
Е	0.018	0.023	0.46	0.58	
F	0.037	0.043	0.94	1.09	
G	0.090	BSC	2.29 BSC		
н	0.034	0.040	0.87	1.01	
J	0.018	0.023	0.46	0.58	
К	0.134	0.142	3.40	3.60	
R	0.180	0.215	4.57	5.46	
V	0.035	0.050	0.89	1.27	
W	0.000	0.010	0.000	0.25	

#### **IPAK (STRAIGHT LEAD DPAK)** CASE 369D-01 ISSUE B





- NOTES: 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH.

	INCHES		MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.35
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
Е	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.090	) BSC	2.29 BSC	
Н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
κ	0.350	0.380	8.89	9.65
R	0.180	0.215	4.45	5.45
S	0.025	0.040	0.63	1.01
V	0.035	0.050	0.89	1.27
Ζ	0.155		3.93	

STYLE 2: PIN 1. GATE DRAIN
SOURCE

4. DRAIN

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